Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/516,797	YANASHIMA ET AL.	
Examiner	Art Unit	
B. Chen	1762	

SEARCHED							
OLAI(O) LD							
Class	Subclass	Date	Examiner				
427	66 67 126.1	2/16/2006	вс				
	157						

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	<u></u>				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR	
east		2/16/2006	вс	
·				